



Model: TOSHIBA AL14SEB060N S/N: 8660A001F09C

Disk Erasure Report





Organisation Performing The Disk Erasure

Business Name: GridJet

Business Address:

Contact Name: GDW-LDS-0 Contact Phone:

Customer Details

Name: Gridjet

Address:

Contact Name: Contact Phone:

Disk Information

Make/Model: TOSHIBA AL14SEB060N Serial: 8660A001F09C

Size(Apparent): 600 GB, 600127266816 bytes Bus: SAS

Size(Real): 600 GB, 600127266816 bytes

Disk Erasure Details

Start time: 2025/02/15 10:38:49 End time: 2025/02/15 13:48:04

Duration: 03:09:15 Status: **ERASED** See Warning!

Method: PRNG Stream PRNG algorithm: XORshiro256

Final Pass(Zeros/Ones/None): Zeros Verify Pass(Last/All/None): Verify Last

*Bytes Erased: 600127266816, (100.00%) Rounds(completed/requested): 1/1

HPA/DCO: Unknown HPA/DCO Size: Unknown

Errors(pass/sync/verify): 0/0/0 Throughput: 158 MB/sec

Information: Warning HPA/DCO data unavailable, can not determine hidden sector status.

Technician/Operator ID Signature:

Name/ID: Auto Wipe

^{*} bytes erased: The amount of drive that's been erased at least once





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smartctl 7.2 2020-12-30 r5155 [x86_64-linux-5.14.0-503.22.1.el9_5.x86_64] (local build) copyright (c) 2002-20, bruce allen, christian franke, www.smartmontools.org

=== start of information section === vendor: TOSHIBA product: AL14SEB060N revision: DM05 compliance: SPC-4

user capacity: 600,127,266,816 bytes [600 GB]

logical block size: 512 bytes formatted with type 2 protection

8 bytes of protection information per logical block

rotation rate: 10000 rpm form factor:

2.5 inches 0x50000397381264e5 logical unit id:

serial number: 8660A001F09C

device type: disk transport protocol: SAS (SPL-3)

local time is: Sat Feb 15 13:48:05 2025 GMT smart support is: Available - device has SMART capability. smart support is: Enabled

temperature warning: Disabled or Not Supported

=== start of read smart data section ===

smart health status: OK

30 C current drive temperature: drive trip temperature: 65 C

accumulated power on time, hours:minutes 45398:01

manufactured in week 31 of year 2016

specified cycle count over device lifetime: 50000

accumulated start-stop cycles: 39

specified load-unload count over device lifetime: 600000

accumulated load-unload cycles: 20547

elements in grown defect list: 0

error counter log:

	errors	corrected	. by	total	correction	gigabytes	total		
	ecc		rereads/	errors	algorithm	processed	uncorrected		
	fast	delayed	rewrites	corrected	invocations	[10^9 bytes]	errors		
read:	0	9246	9246	9246	191640	1381575.987	0		
write:	0	1	1	1	1	45856.976	0		
verify:	0	0	0	0	0	90672.786	0		

non-medium error count:

smart self-test log

num	test	status	segment	lifetime	lba_first_err	[sk	asc	asq]	
	description		number	(hours)					
# 1	background short	completed	80	3	-	[-	-	-]	
# 2	reserved(7)	completed	64	3	_	[-	_	-]	

long (extended) self-test duration: 4107 seconds [68.5 minutes]